

**Notice of References Cited**Application/Control No.  
**09/634,764**Applicant(s)/Patent Under Reexam  
**Carlbon et al.**Examiner  
**Thai Phan**Art Unit  
**2123**

Page 1 of 1

**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	5,467,401	11/1995	Nagamitsu et al.	381	63
B	5,491,644	2/1996	Pickering et al.	364	514 R
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**NON-PATENT DOCUMENTS**

	<b>Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages</b>
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